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Dynamic scanning probe microscopy of adsorbed molecules on graphite

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We have used a combined dynamic scanning tunneling and atomic force microscope to study the organization of weakly bound adsorbed molecules on a graphite substrate. These weakly bound molecules may be imaged in dynamic scanning tunneling microscopy (STM) mode in which the probe is oscillated above the surface. We show that molecular resolution may be readily attained and that a similar mode of imaging may be realized using conventional STM arrangement. We also show, using tunneling spectroscopy, the presence of an energy gap for the adsorbed molecules confirming a weak molecule-substrate interaction. © 2009 American Institute of Physics.

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Shortly after the invention of scanning probe microscopy, the imaging of adsorbed molecules emerged as a major theme of research, which has since grown to encompass manipulation and self-assembly phenomena and is also highly relevant to organic electronics.1–4 While the initial focus was on the use of scanning tunneling microscopy (STM) to acquire images with molecular resolution, there has recently been great progress in applying atomic force microscopy (AFM) to the imaging of adsorbed molecules.5 Images have now been acquired by a number of groups using either cantilevers or quartz tuning forks (TFs) as force sensors.6,7 Within this body of work the approach of Giessibl and co-workers8–10 is particularly attractive since it is well suited to the simultaneous measurement of tunnel currents and force gradients. In addition this approach has led to different imaging modes such as dynamic STM.10

In this paper we show that it is possible to resolve single molecules using dynamic STM and also demonstrate additional attractive features such as improved stability, as compared with conventional STM. We also show that these advantages may be realized using a conventional STM tip. For the molecule studied, perylene tetracarboxylic di-imide (PTCDI) adsorbed on graphite, we also observe a reproducible contrast inversion in the dynamic mode of STM.

The instrument we have constructed and used for our experiments is a scanning probe microscope based on TF force sensor,7 which is operated under ultrahigh vacuum (UHV) conditions at room temperature. The instrument can operate in three different regimes in conjunction with the TF sensor: (spring constant k=1800 N/m): dynamic AFM in constant frequency mode (feedback signal: frequency shift); conventional (dc) STM in constant current mode (feedback signal: tip-sample current); and dynamic (ac) STM in constant average current mode (feedback signal: time averaged tip-sample current). For dynamic STM/AFM measurements the TF is mechanically excited using a small segment of the same piezotube used for x, y, z movement of the TF. For a metallic tip we use an electrochemically etched 25 μm diameter PtIr wire glued at the end of the TF and cleaned in UHV by Ar ion sputtering. After attachment of the tip the resonant frequency (measured in UHV) of the TF, fo, is in the range of 25–32 kHz with a Q-factor of 2000–5000. The tip is electrically isolated from the TF electrodes and connected to the tunnel current preamplifier by a separate electrical connection. The bias voltage is applied to the sample.

Our experimental arrangement also permits the attachment of a conventional STM tip (we use cut PtIr wire), rather than the TF sensor, to the piezoelectric scanner. Dynamic STM is also possible in this configuration and can be realized by applying an sinusoidal signal to the piezoelectric scanner in order to induce an oscillatory motion of the tip (frequency of 29 kHz, amplitude of 0.2–0.3 nm) perpendicular to the surface (defined as the z direction). In all cases GXSM software11 is used for control/data acquisition and WSXM for image processing.

A highly oriented pyrolytic graphite (HOPG) sample was cleaved in air and transferred immediately into a UHV chamber. PTCDI was sublimed onto the HOPG substrate (held at room temperature) at an approximate deposition rate of 0.2 ML/min. Deposition of PTCDI results in the formation of highly faceted rodlike islands with typical widths of ~6 nm. These islands grow across step edges and form branched structures as imaged in the AFM mode of operation [Fig. 1(a)]. Second layer formation starts even for submonolayer coverage indicating a Volmer–Weber growth mode, which might be expected for a passive substrate such as graphite, and has also been observed in earlier reports of PTCDI growth on MoS2.12 Interestingly, while there have been many studies of adsorbed molecules on graphite at a liquid/solid interface,13 there have been relatively few STM studies performed under vacuum conditions, and many of the published images were acquired at low temperature.15–17 One reason for this is the relatively weak adsorbate-graphite interaction, which results both in rapid diffusion of adsorbates and also gives rise to the potential for damage of any overlayers through interaction with the STM tip.

STM imaging (dc mode) of the PTCDI islands often results in island disruption presumably due to tip-molecule interactions (see above). Such tip-induced surface modification is demonstrated in Fig. 1(b) where the double-layer island is significantly disrupted following several consecutive scans using a tip mounted on a TF sensor in dc-STM mode. However, images of PTCDI islands can be readily acquired using dynamic STM. We reiterate that in this mode, a time averaged tunnel current between sample surface and oscillating tip is used to control probe height. Figure 1(e) shows a
A high resolution dynamic STM image in Fig. 1(g) reveals a close-packed arrangement of PTCDI with a unit cell of $1.5 \times 1.8$ nm$^2$. The elongated shape of the islands can be explained by anisotropy of intermolecular interactions, which arises from the interaction of imide and carbonyl groups on neighboring molecules as was previously observed for PTCDI and related molecules.$^{18,19}$

To determine the origin of the negative contrast in Fig. 1, we have acquired a set of images of PTCDI islands using dynamic STM with a conventional (non-TF) tip for several different applied bias voltages. These images show that for large absolute bias voltages (1.5 and $-1.7$ V) a positive contrast is observed [Figs. 2(a) and 2(d), respectively], whereas for smaller absolute bias (0.8 and $-1.0$ V) negative contrast is observed similar to that observed in Fig. 1. For the lower absolute voltages it is not possible to acquire images in d-STM. Also shown in Fig. 2 is an $I(V)$ curve acquired with the tip positioned (statically) over either the graphite or a PTCDI island. A tunneling gap is clearly present over the PTCDI molecules, and this low tunnel current region accounts for the negative contrast that we observe. The large tunneling gap observed when the tip is placed above a molecule indicates that, as expected, the electronic coupling between molecule and surface is rather weak.
To investigate further the contrast in dynamic STM we compare in Fig. 3 the variation in frequency shift $\langle df \rangle$ and average current $\langle I \rangle$ with $z$, the tip position, acquired above either the bare graphite or a PTCDI island. There is noticeable broadening of the dependence of $\langle df \rangle$ on $z$ (tip position) over a PTCDI island. In addition, the $\langle I \rangle$ versus $z$ curve has a much less rapid rise as compared with the equivalent curve acquired on the bare HOPG surface.

To model the average current versus distance dependence we use the common approximation for tunnel current dependence on work function for conventional STM, which leads for dynamic STM to the following expression for average tunnel current:

$$\langle I \rangle = I_0 \int_0^{1/f_0} \exp\left(-2a\varphi^{1/2}[z + A_{osc} \sin(2\pi f_0 t)]\right) dt$$

$$= I_0 \exp\left(-2a\varphi^{1/2}z\right)J_0(2aA_{osc}\varphi^{1/2}),$$

where $J_0$ is the modified Bessel function of the first kind, $A_{osc}$ is the amplitude of the tip oscillation, $\varphi$ is the work function, and $a=(2m)^{1/2}/h$. The exponential dependence of $\langle I \rangle$ on $z$ is consistent with our experimental measurements (Fig. 3).

Overall our results show that in regions where contrast inversion occurs, which might be expected for weakly bound molecules, image acquisition using conventional dc-STM is difficult, if not impossible, but images can be acquired with molecular resolution using dynamic STM. We argue that the reason for the enhanced imaging stability is the oscillatory motion of the STM tip, which means that when in close proximity to the molecules, the tip is moving perpendicular to the surface. A consequence of this is that as the tip passes over the molecular islands (including the edges), the lateral forces that are generated between tip and molecule are expected to be much lower than those that occur for conventional imaging [and are well known to lead to molecular displacement across surfaces (see, for example, Ref. 21)].

The relative stability of dynamic STM may be considered analogous to the enhanced stability of tapping mode, as compared with contact-mode AFM. The curves shown in Fig. 3 support the presence of significant tip-molecule forces through the broadening of the minimum of the force-gradient versus height curve.

In conclusion, we have demonstrated that dynamic STM may be used to acquire structural and electronic measurements for molecular assemblies weakly bound to a substrate. For the case of PTCDI nanosized islands on a graphite surface, the stability and resolution that may be attained in dynamic STM is significantly better than under dc-STM. Furthermore, we demonstrate that dynamic STM may be realized in a conventional (non-TF) STM and that this imaging technique therefore has the potential to be applied to a wide range of materials where stable image acquisition is not possible using dc-STM.

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